- Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages, and Plastic and Ceramic DIPs
- Dependable Texas Instruments Quality and Reliability

description

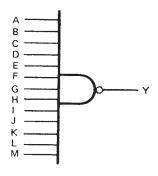
These devices contain a single 13-input NAND gate.

The SN54133 is characterized for operation over the full military temperature range of $-55\,^{\circ}\text{C}$ to 125 $^{\circ}\text{C}$. The SN74133 is characterized for operation from 0 $^{\circ}\text{C}$ to 70 $^{\circ}\text{C}$.

FUNCTION TABLE

INPUTS A THRU M	OUTPUT Y
All inputs H	L
One or more inputs L	Н

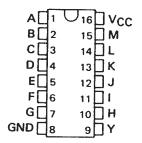
logic diagram



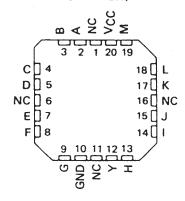
positive logic

$$\begin{array}{l} Y \,=\, \overline{A} \,\cdot\, \underline{B} \,\cdot\, \underline{C} \,\cdot\, \underline{D} \,\cdot\, \underline{E} \,\cdot\, \underline{F} \,\cdot\, \underline{G} \,\cdot\, \underline{H} \,\cdot\, \underline{I} \,\cdot\, \underline{J} \,\cdot\, \underline{K} \,\cdot\, \underline{L} \,\cdot\, \underline{M} \quad \underline{or} \quad \underline{} \\ Y \,=\, \overline{A} \,+\, \underline{B} \,+\, \overline{C} \,+\, \overline{D} \,+\, \overline{E} \,+\, \overline{F} \,+\, \overline{G} \,+\, \overline{H} \,+\, \overline{I} \,+\, \overline{J} \,+\, \overline{K} \,+\, \overline{L} \,+\, \overline{M} \\ \end{array}$$

SN54S133 . . . J OR W PACKAGE SN74S133 . . . D OR N PACKAGE (TOP VIEW)

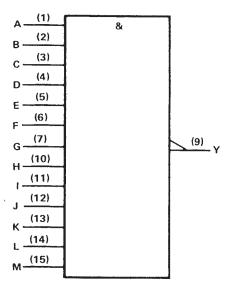


SN54S133 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

logic symbol†

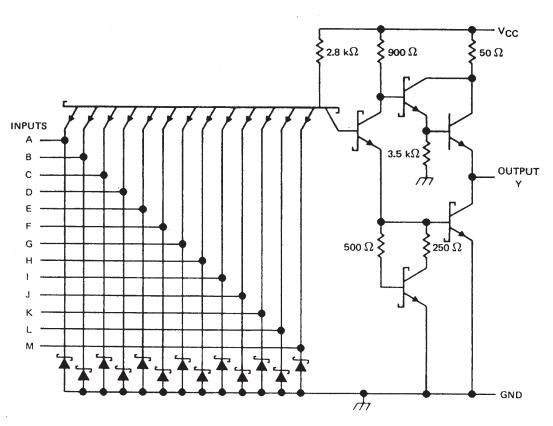


[†]This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.



'S133



Resistor values shown are nominal.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (see Note 1)	7 V
Input voltage	5.5 V
Operating free-air temperature range: SN54'	- 55°C to 125°C
SN74'	0° C to 70° C
Storage temperature range	- 65° C to 150° C

NOTE 1: Voltage values are with respect to network ground terminal.



recommended operating conditions

			SN54S133			SN74S133		
		MIN	NOM	MAX	MIN	NOM	MAX	UNIT
VCC	Supply voltage	4.5	5	5.5	4.75	5	5.25	V
VIH	High-level input voltage	2			2			V
VIL	Low-level input voltage			0.8			8.0	v
ЮН	High-level output current			– 1			- 1	mA
loL	Low-level output current			20			20	mA
TA	Operating free-air temperature	- 55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS †			SN54S133			SN74S133			
	TEST CONDITIONS I			MIN	TYP‡	MAX	MIN	TYP‡	MAX	UNIT
VIK	V _{CC} = MIN,	I _I = -18 mA				-1.2			-1.2	٧
VOH	V _{CC} = MIN,	V _{IL} = 0.8 V,	I _{OH} = -1 mA	2.5	3.4		2.7	3.4		V
VOL	V _{CC} = MIN,	V _{IH} = 2 V,	IOL = 20 mA			0.5			0.5	V
11	V _{CC} = MAX,	V ₁ = 5.5 V				1			1	mA
11Н	V _{CC} = MAX,	V ₁ = 2.7 V				50			50	μА
lı L	V _{CC} = MAX,	V ₁ = 0.5 V				-2			-2	mA
I _{OS} §	V _{CC} = MAX			40		-100	-40		-100	mA
1ссн	V _{CC} = MAX,	V _I = 0 V			3	5		3	5	mA
ICCL	V _{CC} = MAX,	V ₁ = 4.5 V			5.5	10		5.5	10	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CON	MIN TYP	MAX	UNIT	
^t PLH			R _{L.} = 280 Ω,	C _L = 15 ρF	4	6	ns
^t PHL					4.5	7	ns
^t PLH	Any		R _L = 280 Ω,	C _L = 50 pF	5.5		ns
^t PHL					6.5		ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.



[‡] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$. § Not more than one output should be shorted at a time, and the duration of the short-circuit should not exceed one second.

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